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Property enhancement of a close-spaced sublimated CdTe thin film by a post-growth activation step with CdCl₂ and MgCl₂

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The deposition parameters utilized during cadmium telluride (CdTe) film formation can regulate the microstructure of the absorber layer, which is crucial to photovoltaic conversion. In this study, borosilicate glass substrates are coated with CdTe thin films using the close-spaced sublimation approach under various argon pressures. At low pressure, a relative increase in grain size could be seen. A non-toxic magnesium chloride (MgCl₂)-based activation procedure of the CdTe thin film absorber layer has been followed and contrasted with the conventional cadmium chloride (CdCl₂) for solar cell applications. X-ray diffraction (XRD), Raman spectroscopy, scanning electron microscopy (SEM), electron dispersive spectroscopy (EDS), and ultraviolet-visible spectroscopy (UV-Vis) analyses of the impacts of the CdCl₂ and MgCl₂ activation treatment revealed the crystallization, morphology, composition, and optical attributes of the CdTe thin film. The Raman peak at 141 cm⁻¹ is accredited to a mixture of CdTe's transversal optic phonons after chloride treatment. The main diffraction peaks, corresponding to the (111), (220), and (311) cubic plane according to JCPDS card number 96-900-8841, appear prominently at $2\theta = 23.8^\circ$, 39.29° and 46.91° , respectively. The SEM image reveals that crystals in the MgCl₂-treated CdTe thin film are quite highly textured. In addition, the treated CdTe samples show less absorbance than CdTe where the band gap varies between 1.48 and 1.56 eV and the refractive index ranges from 2.8–2.9, and the treatment effect is not that prominent. However, based on other structural and optical factors, it is evident that MgCl₂ is the ideal activator for industrial purposes because it is eco-friendly, non-toxic, affordable, and provides comparable efficiency to conventional toxic CdCl₂ activators.

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1. Introduction

For explicit energy applications, integrated photovoltaics in buildings, unmanned vehicles, or in space, thin-film devices are extremely attractive.¹ Cadmium telluride has been entrenched as the premier thin-film photovoltaic technology. It is a simple binary compound and is a direct band gap semiconductor material. Near stoichiometric CdTe which is the most stable phase is easy to fabricate and dissolves evenly. Additionally, CdTe can be synthesized using a variety of techniques.² The development of CdTe technology aims to reduce energy production costs while also minimizing the ecological impact of indirect pollution. The pricing of CdTe solar cells has now fallen below \$0.46 per Watt, pushing power generation costs closer to grid parity.^{3,4}

Based on the material's configuration and exterior dopants introduced, CdTe will be present in p-type, i-type, or n-type conduction methods.⁵ Tellurium-rich CdTe layers behave as

n-type materials, whereas cadmium-rich CdTe layers do the opposite. Reliant on the original electrical conduction type of the precursor material, the accumulation of an n-type dopant (Cl) to CdTe may provide a wide range of effects. Owing to self-compensation from inherent imperfections such as vacancies (V_{Cd}, V_{Te}), interstitial defects, or grain boundaries,^{6,7} CdTe has the disadvantage of it being difficult to attain large doping concentrations. Thus, these are the major hurdles in improving the power conversion efficiency of CdTe solar cells. For high conversion efficiency, the post-growth activation stage is an essential aspect of the CdTe solar cell design process. This is necessary for attaining high device efficiencies because it forms the photovoltaic junction at the CdTe/CdS interface⁸ to promote the growth of grains and recrystallization⁹ for passivation of the grain boundaries.¹⁰ This step also facilitates the p-type doping of the CdTe absorber layer.¹¹ A variety of methods for cadmium chloride (CdCl₂) deposition have been used, including methanolic solution and direct vapor exposure. Preceding annealing in an air or oxygen environment,¹² the far more popular method is to apply a thin CdCl₂^{13,14} coating to the back

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surface *via* thermal evaporation. CdCl₂ is common in CdTe device activation,¹⁵ with a few significant outliers, like handling in the presence of freon gas, as Romeo *et al.* observed.¹⁶ However, CdCl₂ has two significant drawbacks. First, it is expensive (~30 cents per g). Secondly, water-soluble Cd²⁺ is a potentially mobile source of hazardous elements posing a risk to personnel and the environment as well.¹⁷ However, the most expensive part of CdCl₂ production is its processing and waste disposal, which necessitates a specialized industrial plant for the operator's safety. As a result, it's appealing to look into nontoxic and low-cost alternative chloride sources for post-growth treatment of CdTe absorber thin films as remarkably, there seems to be little existing research in this domain.

Cadmium chloride has been used for over 30 years¹⁸ and there have been relatively few efforts to utilize alternatives; for example, doping of Au or Cu,¹⁹ HCl,²⁰ NaCl and KCl²¹ and NH₄Cl^{22,23} treatments have been reported but with little success. In this study, a post-activation solution treatment using MgCl₂ along with CdCl₂ is illustrated which previously showed efficiencies (~13%) for vapor treatment identical to those of a CdCl₂-treated group.²¹ Consequently, it is nontoxic and costs less than a cent per g. It possesses comparable hole densities in the active layer ($9 \times 10^{14} \text{ cm}^{-3}$) along with contamination profiles for Cl and O, which are key p-type dopants in CdTe thin films.²¹ CuCl₂ and ZnCl₂, for example, were not considered because they pose an environmental danger or have a high cost. One significant finding is that polycrystalline CdTe cells are considerably superior to single-crystal cells when followed by Cl₂ heat treatment. Then, the grain boundaries actively aid the carrier collecting efficiency rather than serving as recombination hotspots.²⁴ This suggests that the key to producing high-efficiency solar cells is the accumulation of Cl₂ at the grain boundaries by Cl₂ treatment. In our previous work, there is a correlation between the structural and optoelectronic properties of CdTe thin films with the variation of the Argon pressure.²⁵ This correlation indicates significant commercial certainty. We have used the same samples to study the post-growth treatment with two selective chlorides for this study. The effect of MgCl₂ and CdCl₂ treatment on the properties of CdTe thin films is optimized and compared in this communication for solar-cell applications as a consequence of as-deposited CdTe^{1,26} which will contribute towards the understanding of this activation step. MgCl₂ has potential as a non-carcinogenic low-cost alternative to CdCl₂ without sacrificing device performance or requiring major changes in processing techniques. Our findings show that CdCl₂

can be swapped immediately with MgCl₂²⁷ in the conventional manufacturing process, reducing both the costs and environmental risk of CdTe photovoltaic module utilization. However, there is still a lot of room for exploration.

2. Experimental

2.1. Thin film deposition

The CdTe thin film is grown on borosilicate glass (BSG) by a close-spaced sublimation (CSS) method under ambient argon (Ar) with the source temperature and substrate temperature as 625 °C and 585 °C, respectively. The source and substrate are separated by 2 mm and the deposition pressure of the CSS chamber is varied from 250–1000 mTorr to identify the suitable deposition ambient for the CdTe thin film. The deposition process is continued for 10 min to fabricate a CdTe thin film. After that the unit is left for a while for self-cooling and the sample is collected later. The whole procedure is vividly described in a previous study.²⁵

2.2. Chloride treatment

The CdTe thin film is etched with CdCl₂ and MgCl₂ for 3 s preceding to post-growth heat treatment to boost the Cl in-diffusion into the CdTe thin film. The samples are then desiccated with N₂ flow. The heat treatment periods for the MgCl₂ and CdCl₂ treatments are 15 min at 390 °C with a ramp of 10 °C min⁻¹. The samples are annealed in an air tube furnace with N₂ flow maintained at 40 sccm. After self-cooling, the CdTe thin film is collected for characterization. The conditions of different deposition and post-growth activation steps are listed in Table 1. As the soda lime glass (SLG) substrate contains about 4% MgO,²¹ to exclude the effect of Mg, BSG is used as a regular substrate for this study.

2.3. Characterization

All treated CdTe absorber thin films were subjected to X-ray diffraction (XRD) to determine the microstructure of the film. Cu-K radiation with a wavelength of 1.5406 is used in a GBC, EMMA (Australia) diffractometer to record XRD patterns. Raman spectroscopy (LabRAM HR Evolution, Horiba Scientific, Japan) is used to obtain the compounds' unique structural fingerprints. To investigate the optical absorbance at the visible wavelength, a UV-visible spectrophotometer (UH4150, Hitachi) is used. Film morphology is observed with a scanning electron microscope (SEM, EVO18, Zeiss). Energy-dispersive X-ray spectroscopy (EDX)

Table 1 Different deposition and chloride treatment conditions for the CdTe thin films

| Sample | Source temp. | Substrate temp. | Source-substrate spacing | Deposition time | Deposition pressure (Ar) | Treated with |
|-----------|--------------|-----------------|--------------------------|-----------------|--------------------------|-------------------|
| P 250 Cd | 625 °C | 585 °C | 2 mm | 10 min | 250 mTorr | CdCl ₂ |
| P 500 Cd | | | | | 500 mTorr | |
| P 750 Cd | | | | | 750 mTorr | |
| P 1000 Cd | | | | | 1000 mTorr | |
| P 250 Mg | | | | | 250 mTorr | MgCl ₂ |
| P 500 Mg | | | | | 500 mTorr | |
| P 750 Mg | | | | | 750 mTorr | |
| P 1000 Mg | | | | | 1000 mTorr | |



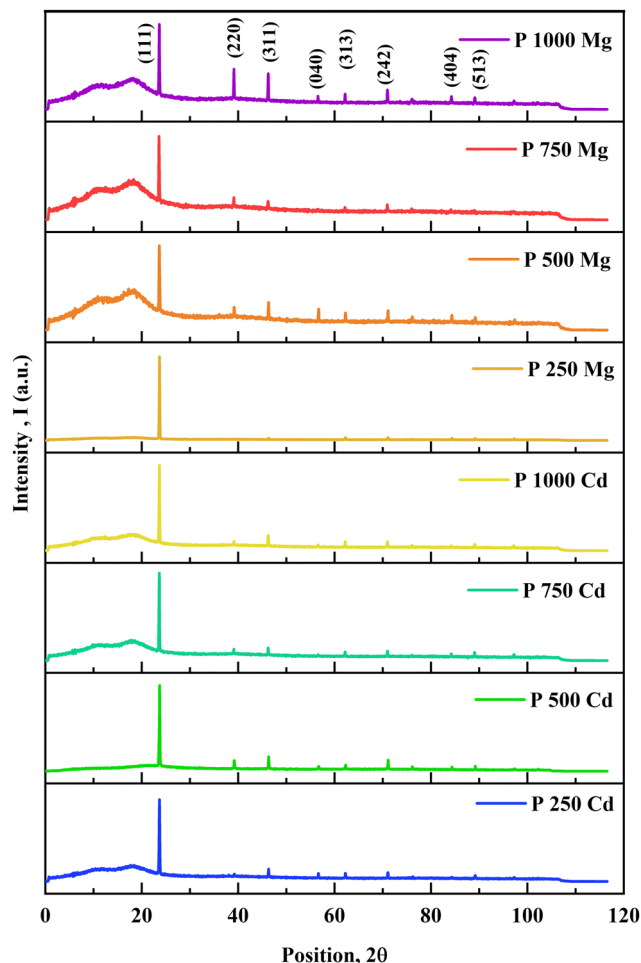


Fig. 1 The XRD pattern of CdTe thin film after different post growth treatment.

was utilized to examine the chemical configuration of the film, using an EDS system (EDAX, AMETEK, USA) mounted to the scanning electron microscope. The beam voltage is maintained at 15 kV.

3. Results and discussion

3.1. Structural characterization

From the X-ray powder diffraction (XRD) data, the structural and crystallographic characteristics of the CdCl₂ and MgCl₂-treated

CdTe films are investigated. X-ray diffraction as shown in Fig. 1 demonstrates that the deposited films are polycrystalline and the main diffraction peak, which corresponds to the crystal orientation at the (111) cubic plane according to JCPDS card number 96-900-8841, appears prominently at $2\theta = 23.8^\circ$ for all treated films. The (220) and (311) planes are represented by two additional small intensity peaks at latitudes $2\theta = 39.29^\circ$ and $2\theta = 46.91^\circ$, respectively.¹⁵ The average crystallite sizes (D) of the films are determined by the Scherrer formula^{25–27} to provide additional structural features. However, it is depicted in Fig. 1 that some other less intense peaks are visible at (040), (313), (242), (404) and (513) for MgCl₂-treated CdTe films.

The estimated values of different microstructural parameters for CaCl₂ and MgCl₂-treated CdTe thin films are listed in Table 2. This illustrates significantly lower FWHM for all treated samples, which confirms larger crystallite size compared to the as deposited film.²⁵ The average crystallite size for the CdCl₂-treated film has simultaneously increased from 67 to 74 nm. And it ranges from 71 to 82 nm for MgCl₂-treated CdTe samples,²⁸ whereas it varies from 15 to 16 nm for as-deposited films.²⁴ So obviously a drastic change in crystal size is observed.

A comparison of the microstructural data among as-deposited and treated samples is depicted in Fig. 2(a) to (d). Studies reveal that smaller grains vanish and newly formed larger grains are seen after CdCl₂ treatment.^{18,29} This mostly happens for low-temperature deposition ($\sim 450^\circ\text{C}$) when as-deposited particles are tiny and the grain size is greatly enhanced after Cl treatment.⁷ Consequently, it provides the benefits of larger crystallite size, lower dislocation density, and strain. Comparatively larger crystallite size is observed for MgCl₂-treated samples. However, according to the study, for higher temperature deposition ($\sim 620^\circ\text{C}$) methods, with the probable exclusion of some near-CdS interface recrystallization, the as-deposited grain size is nearly comparable to the chloride-cured particle size.³⁰ However, there might be grain growth or not, but the CdCl₂ treatment results in a significant improvement in device effectiveness in both situations.⁵ It is possible that they're linked to intra-grain passivation instead in the case of high temperature CdTe film deposition.³⁰ Additional research is being done to support this theory. In addition, 1.1 mm BSG has been used as a substrate for this experiment with a thermal expansion coefficient (CTE) of $3.3 \times 10^{-6} \text{ K}^{-1}$. The CTE of ultra-thin glass (UTG) is $7.2 \times 10^{-6} \text{ K}^{-1}$, which is close to the CTE of CdTe ($5.9 \times 10^{-6} \text{ K}^{-1}$).³¹ The reduction of tensile or compressive stress during the cooling

Table 2 Structural parameters of CdCl₂ and MgCl₂-treated CdTe thin films for the (111) plane

| Sample | Position 2θ (deg) | d_{hkl} (Å) | FWHM (deg) | Crystallite size, D (nm) | Dislocation density, $\delta \times 10^{14}$ (lines per m ²) | Strain, $\varepsilon \times 10^{-4}$ | Crystallite no, $N \times 10^{12}$ (m ⁻²) | Degree of crystallinity (%) |
|-----------|--------------------------|---------------|------------|----------------------------|--|--------------------------------------|---|-----------------------------|
| P 250 Cd | 23.665 | 3.7566 | 0.1589 | 67 | 2.26 | 7.68 | 1.27 | 31.98 |
| P 500 Cd | 23.723 | 3.7475 | 0.1517 | 68 | 2.16 | 7.78 | 1.19 | 28.16 |
| P 750 Cd | 23.636 | 3.7611 | 0.1467 | 73 | 1.87 | 6.89 | 0.96 | 31.26 |
| P 1000 Cd | 23.665 | 3.7566 | 0.1428 | 74 | 1.82 | 6.90 | 0.92 | 31.19 |
| P 250 Mg | 23.694 | 3.7520 | 0.1281 | 82 | 1.50 | 6.38 | 0.69 | 35.17 |
| P 500 Mg | 23.636 | 3.7611 | 0.1768 | 73 | 1.87 | 6.89 | 0.96 | 31.68 |
| P 750 Mg | 23.578 | 3.7702 | 0.1384 | 80 | 1.58 | 6.13 | 0.75 | 30.70 |
| P 1000 Mg | 23.636 | 3.7611 | 0.1502 | 71 | 1.96 | 7.05 | 1.03 | 31.25 |



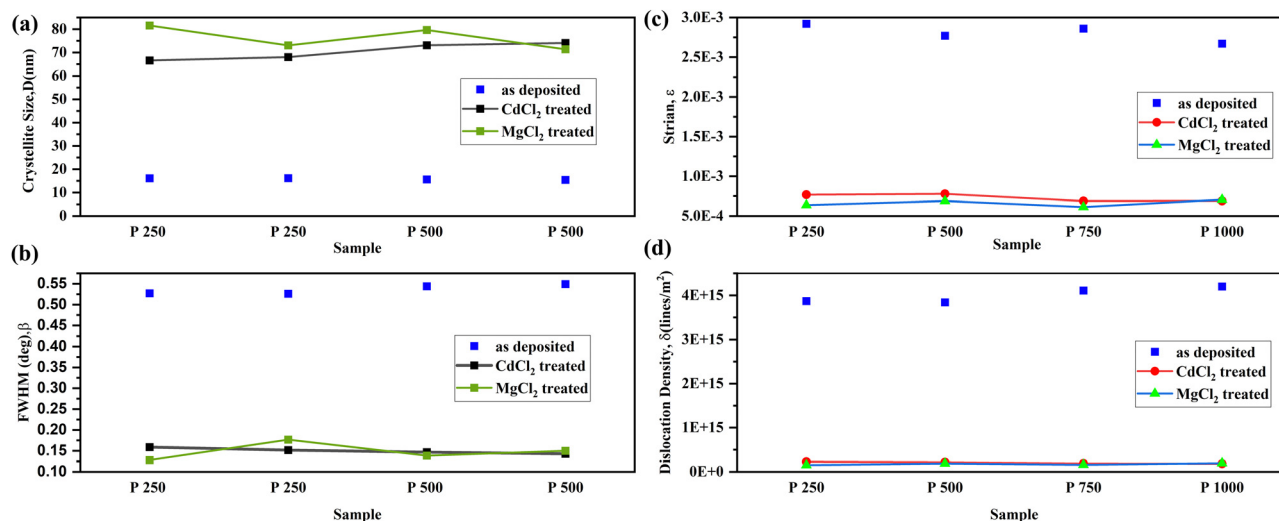


Fig. 2 Comparative illustration of different micro-structural parameters for as-deposited and CdCl₂ and MgCl₂-treated CdTe thin films: (a) crystallite size, D , (b) FWHM, (c) strain, and (d) dislocation density, ρ .

process following high temperature or pressure deposition can be achieved by employing a balanced CTE. Therefore, with high bendability and transparency, UTG would be a better substrate replacement with desirable qualities to avert surface stress and dislocation density.

The addition of chloride serves as an n-type dopant in CdTe. Upon annealing with CdCl₂,³² the grain boundary (GB) states and electrical properties undergo notable changes. This occurs as chlorine atoms segregate and occupy tellurium sites at the grain boundary. For example, the Te-Te interaction undergoes a reduction in energy when it transforms into a Te-Cl interaction due to the isolation of one chlorine (Cl) atom per core within the grain boundary (GB).

This isolation causes the antibonding states to be further pushed into the energy range of the band gap. The Te-Cl antibonding states are partially occupied by extra electrons originating from the dopant atoms, resulting in the Cl atoms retaining a positive charge and creating an electrostatic potential. By reducing the energy of the occupied Cd-Cd bonding states, this potential causes them to approach the valence band maximum (VBM).²⁴ The energies of the new antibonding states between Cl-Cl decrease notably as additional Cl atoms are introduced into the GB. As a result, the charge transfer enhances the electrostatic potential, leading to the downward displacement of the unoccupied Cd-Cd bonding states towards the valence band. Hence, it may be inferred that the presence of Cl segregation in all grain boundaries (GBs) will enhance their structural integrity, leading to the formation of a p-n-p junction across the GB.³² Electrons tend to separate along the grain boundaries, while holes are retained within the bulk of the grain. The rate of carrier recombination can be reduced by the built-in field that arises between the grain external (GB) and grain interior (GI) regions, as it assists in the separation of photo-generated carriers.¹⁷ The findings indicate that the bulk carrier density of the CdTe film subjected to MgCl₂ treatment is equivalent to or greater than the bulk carrier density seen in films treated with CdCl₂.

Raman spectra were recorded by using a 532 nm excitation wavelength for the samples prepared under different conditions followed by post-growth treatment by two types of chloride between 100 and 400 demonstrated in Fig. 3(a) and (b). Raman spectra are typically a unique chemical fingerprint for a certain molecule or material to rapidly characterize the chemical composition. Three discrete bands are seen in the spectrum at 92, 120, and 141 cm⁻¹. The production of CdTe is demonstrated by the bands at 141, 163, and 330 cm⁻¹. Elementary Te can be attributed to additional bands at 92 and 120 cm⁻¹, which were not seen in the X-ray pattern.³³ The emission peak at 120 cm⁻¹ corresponds to the A₁ mode of the Te Raman active peak. According to Soares *et al.*,³⁴ the elemental Te band can be found in the CdTe spectra captured using micro-Raman techniques. It is demonstrated that Te aggregates are formed on the sample surface when CdTe is exposed to laser lines with shorter wavelengths than 840 nm. This is likely the cause of the Te signal being present in the Raman spectra but absent from XRD configurations. The next one at 141 cm⁻¹ is attributed to an amalgamation of the CdTe's transversal optical (TO) phonon at 141 cm⁻¹ and the Te peak $E_1(\text{Te})$ at 139 cm⁻¹.³⁵ The CdTe longitudinal optical (LO) phonon is linked to the less intense detected peak at 167 cm⁻¹ visible for a few samples in Fig. 3.³⁶ Raman analysis performed for this work is just to confirm the material and the phase purity by rapidly characterizing the chemical composition of CdTe after post-growth treatment by two types of chloride.

3.2. SEM microstructure

The influence of Cl treatment on the surface morphology of CdTe films is considered using scanning electron microscopy (SEM). Fig. 4(a)–(h) displays the representative images. The dense and granular surface layer is observed for all the treated samples. The columnar-like structure and distinct growth texture, which are devoid of cracks and pinholes, indicate a high quality CdTe film. A completely new microstructure results from the Cl₂ treatment



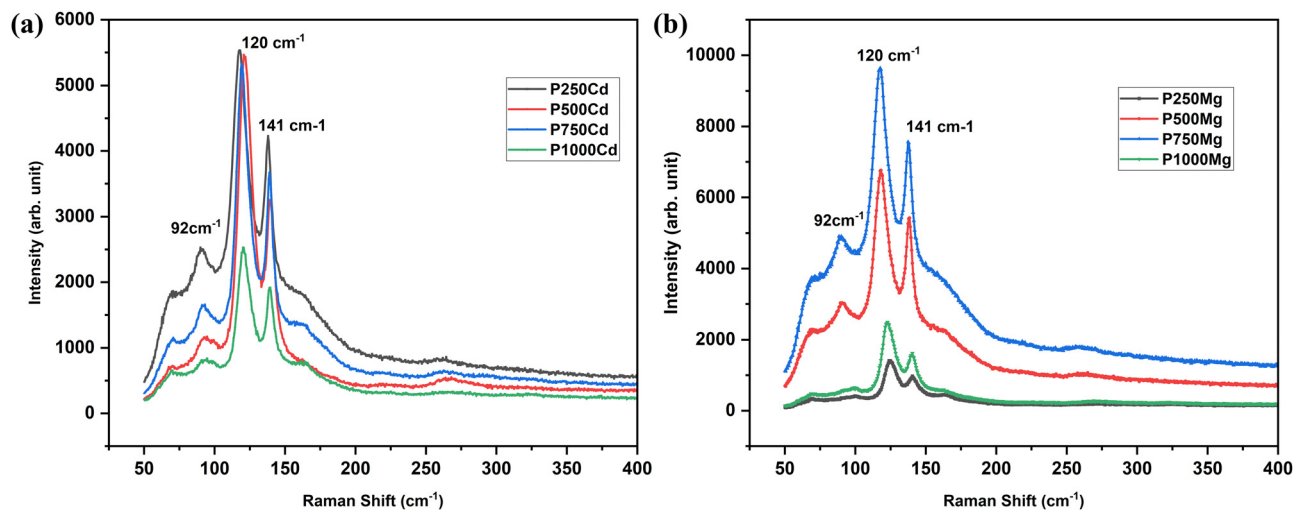


Fig. 3 Raman spectra of (a) CdCl_2 -treated and (b) MgCl_2 -treated CdTe films.

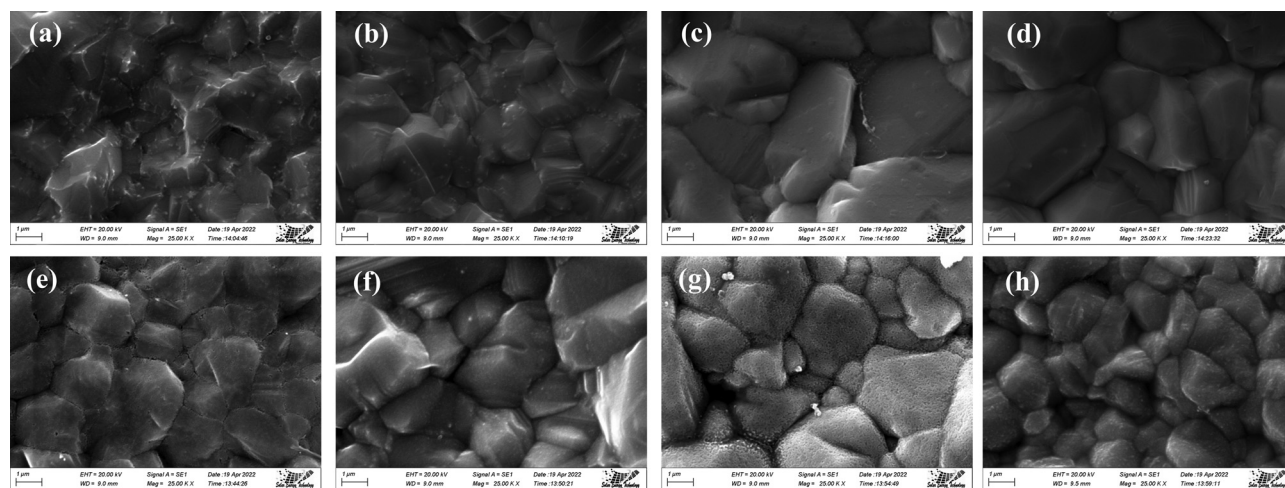


Fig. 4 SEM images of CdTe films for (a) P 250 Cd, (b) P 500 Cd, (c) P 750 Cd, (d) P 1000 Cd, (e) P 250 Mg, (f) P 500 Mg, (g) P 750 Mg and (h) P 1000 Mg.

of the CdTe thin film by re-crystallization, which causes some smaller grains to consolidate into superior ones while other larger grains to fragment into smaller ones and reorganize themselves.³⁷ Smaller grains have greater activity and solubility in the melting flux, which enhances mass carrier movement.³⁸

When the sample is treated with MgCl_2 , the shape of the CdTe films considerably varied (Fig. 4(e)–(h)) in structure. The CdTe thin film treated with MgCl_2 is composed of highly textured and incredibly sharper crystals that have been formed on the grains' surface compared to the CdCl_2 -treated film (Fig. 4(a)–(d)). In comparison to CdCl_2 -treated films, the MgCl_2 -treated film exhibits sharper crystals on the surface of the grains. This implies that the MgCl_2 treatment has a more pronounced effect on crystal formation, leading to sharper and better-defined features. And that is the reason for the comparatively sharp peaks for XRD (Fig. 1) of MgCl_2 -treated CdTe films. The X-ray diffraction (XRD) analysis of the MgCl_2 -treated CdTe films shows comparatively sharp peaks. This indicates that the crystal structure in the MgCl_2 -treated films is more well-defined and organized compared to the CdCl_2 -treated

films. The sharp peaks in XRD typically suggest a more crystalline and ordered structure. In addition, the SEM image presents the average grain size whereas XRD analysis displays measurements relating to crystallite size within the grain.²⁹ The grain sizes may also vary depending on the growth technique²⁵ and conditions,³⁹ which is reported in previous communications.^{1,24}

The impact of chloride treatment on grain boundaries is highly significant, warranting further investigation and study. An accepted concept in solid-state chemistry is that the addition of impurities lowers a material's or compound's melting point. Several contaminants are added to the CdTe surface during the chloride treatment process. Among these are excess elemental Te deposited during development, excess Cd and Cl from CdCl_2 , and O from air annealing.

Furthermore, there will be CdTe crystallites or amorphous CdTe present in the grain boundaries. The melting point of grain boundary materials will be significantly lowered by all of the aforementioned impurities to a heat treatment temperature range of around 350–450 °C. Large CdTe crystals will therefore



continue to exist as solid materials while the components near the grain boundaries will melt into a liquid. This melting temperature has previously been determined to be $385 \pm 5^\circ\text{C}$.⁴⁰ At this point, the thin film abruptly transforms into a group of CdTe crystals floating atop a thin liquid layer that has developed along grain boundaries. When heat treated and then cooled, the CdTe layers produced with (111) preferred orientation abruptly shift as a result of crystals floating in a liquid phase displaying random nature of crystalline orientation. Following this procedure, the majority of the CdTe crystals exhibit columnar character as they expand over the thin film thickness. Convection currents cause the liquid to move freely along grain boundaries during heating, allowing all of the constituents to mix properly, react chemically, and maybe even evaporate from the liquid in excess. Within grain boundaries, excess Cd from CdCl₂ and any elemental Te available can form a CdTe compound. Other elements present, such as Cl, O, and other elements, dope this material to give it a specific electrical conductivity. The CdTe crystals stay solid after cooling, and the material at the grain boundary becomes hardened without creating any pinholes in the thin film in order to create superior solar cells. The introduction of both these features occurs during the CdCl₂ treatment of ED-CdTe, leading to a significant impact.⁴¹ On the other hand, massive crystals in the μm -scale have already been created using high-temperature grown CSS-CdTe.⁴⁰ So, the addition or enhancement has a relatively smaller impact there. However, there is still a benefit to the chloride therapy.

3.3. Composition

According to the EDS spectrogram, all of the samples have similar Cd and Te dominance and authenticate the steadiness of the CdTe thin film through different deposition conditions and treatment. Fig. 5 displays the atomic percentages of Cd, Te, and Cd/Te ratio for the samples. Both CdCl₂ and MgCl₂-treated CdTe thin films displayed a nearly stoichiometric Cd/Te ratio (ratio from 0.84 to 0.88).³³ The results again conclude that CdCl₂ is replaceable with MgCl₂. However, it is noteworthy that for Cd-treated samples, the Cd/Te ratio varies from 0.84–0.88.

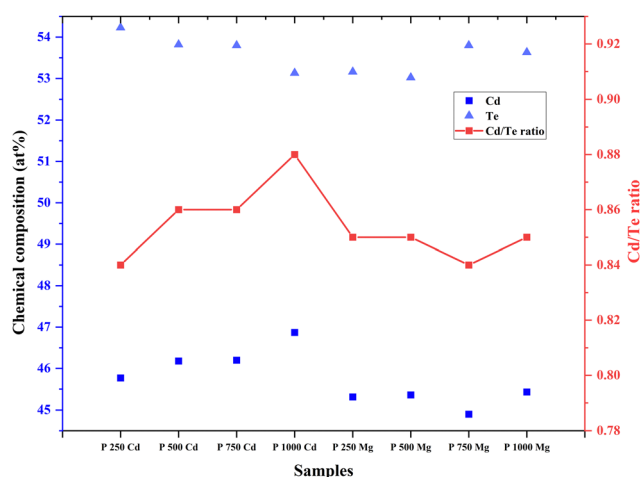


Fig. 5 Atomic percentage of Cd and Te and the ratio of Cd/Te.

And for the Mg-treated sample the ratio varied from 0.84–0.85. The CdCl₂-treated samples as expected show a comparatively higher Cd atomic percentage than the MgCl₂ treated CdTe films. However, Ojo *et al.*⁴² reported an interesting insight that electro-deposited p-type CdTe, rich in Te and n-type CdTe, rich in Cd, together (n–n–p configuration) offer the best efficiency of 15.3% where any treatment was skipped. It is widely known from studies on semi-insulating CdTe that Te precipitation forms in CdTe regardless of the synthesis process.⁴³ The precipitation of Te occurs during the formation of CdTe due to Te's usual compartment and is recognized to be the root of the poor electrical feature of Te-rich CdTe.⁴⁴ The precipitated Te is removed by Cl₂ treatment and annealing. CdTe-based solar cells typically benefit from excess tellurium or precipitated cadmium. Studies show that stoichiometric deviation might alter the band gap of a material.²⁹ The aforementioned findings are in accordance with earlier research^{41,42} and it further demonstrates that the CdTe stoichiometry plays a vital role in cell efficiency. Therefore, it might be concluded that MgCl₂ treatment would be more beneficial to achieve high-efficiency CdTe solar cells.

3.4. Optical analysis

A study of the treated CdTe films' optical attributes is intended to investigate their energy band gap, Urbach energy (E_U), refractive index (n), and extinction coefficient (k) for better understanding. The calculation for estimating these optical parameters is described in a previous report.²⁴ By computing the absorbance of CdTe films, optical properties are examined. In order to mitigate the impact of the fundamental substrate, the absorbance of the reference glass is nullified. Fig. 6 illustrates that the samples treated with CdCl₂ exhibit nearly uniform absorbance across the visible wavelength spectrum. The absorption coefficient (α) value is approximately 10^4 cm^{-1} , which confirms the anticipated absorbance of over 90% for an effective absorber layer. However, MgCl₂-treated samples show comparatively low absorbance ($\sim 88\%$). It is also a suggestion of the thickness consistency of placed films.⁴⁵ However,

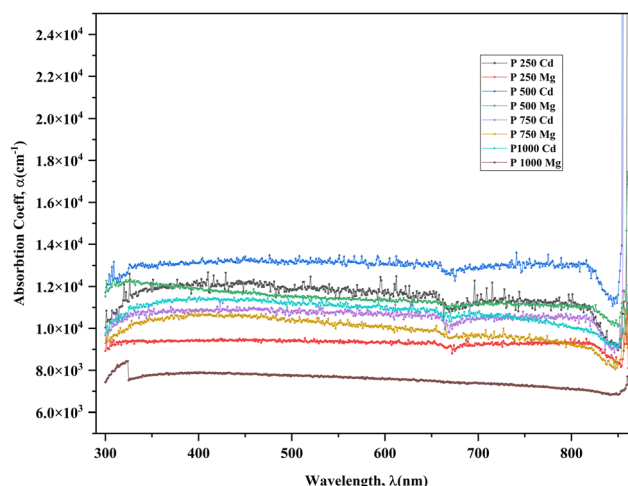


Fig. 6 Absorption coefficient of CdCl₂ and MgCl₂-treated CdTe thin film.



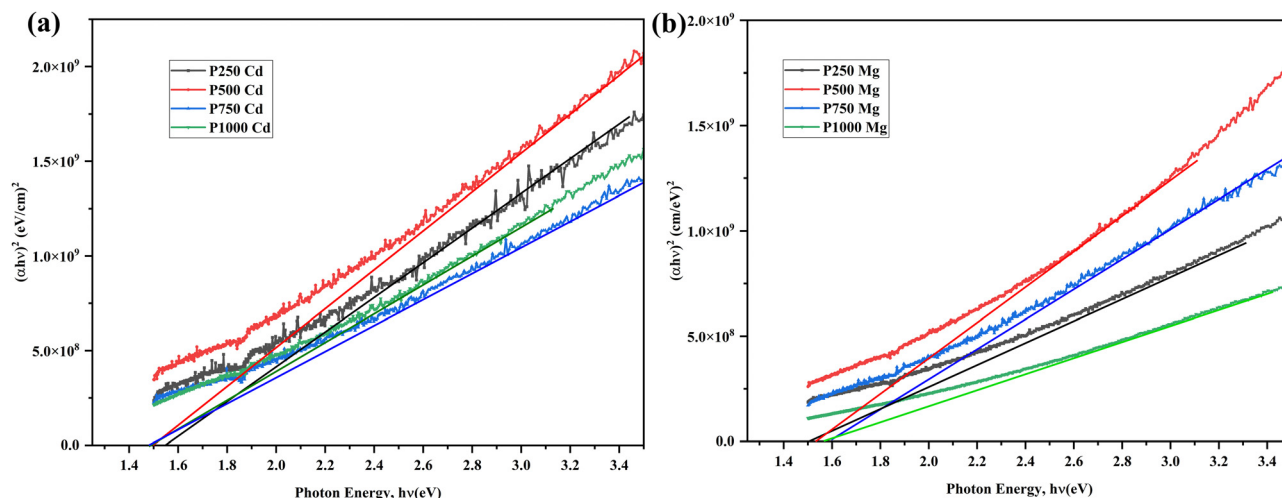


Fig. 7 Tauc plot of treated CdTe thin film with (a) CdCl₂ and (b) MgCl₂.

Fig. 6 depicts that CdCl₂ and MgCl₂-treated samples show comparatively lower absorption coefficient, α than that of as deposited CdTe films.^{24,29} For calculating the absorption coefficient the following classic equation⁴⁶ is used.

$$\alpha = \frac{A(h\nu - E_g)^n}{h\nu} \quad (1)$$

In this context, the variable n represents a constant that can take on the values of 1/2, 2, 3/2, or 3. The specific value of n depends on the type of transition being considered, namely allowed direct, allowed indirect, forbidden direct, or forbidden indirect transitions. The absorbance, which is extremely reliant on the category of surface modification being employed, determines the absorption coefficient. As a result, expanding the absorption area could further improve the value that was achieved. This can be done by decreasing the hole widths, or growing the density of holes, and their depths.³⁶

The Tauc plots derived from the investigational data are shown in Fig. 7(a) and (b). It is possible to determine the energy band gap by extrapolating the linear fit at the absorption limit, $\alpha = 0$. The estimated optical energy band gap of the aforementioned CdTe thin films ranges between 1.48–1.60 eV tabulated in Table 3, in good agreement with previous outcomes.^{13,42} For this study, the incorporation of Cl treatment for post-annealing, induces an insignificant band gap variation, as no

clear trends can be observed. Nevertheless, it can be considered that Cl treatment does not have a substantial conclusion on the band gap for the CdTe films either by CdCl₂ or MgCl₂. Table 3 presents the values of the band gap, refractive index, and dielectric constant of the CdTe thin films that were produced under various argon pressures and subsequently subjected to selective chloride treatment. The obtained results are all in good agreement with former reports.²⁹

When compared to untreated samples, treated samples exhibit an increment in the refractive index and a minor drop in transmittance. Here, there are no discernible changes in refractive index. This might be because the treated samples have the same optical band gap and thickness.²⁹

The spectral dependence of the absorption coefficient, with respect to photon energies ($h\nu$) that are lower than the energy band-gap of a CdTe thin film, can be described by

$$\alpha = \alpha_0 \exp(E/E_U) \quad (2)$$

where α_0 is a constant and E_U is the Urbach energy.^{47,48} The E_U is inferred from the slope of linear fit to the logarithmic plot of α and $h\nu$. However, Fig. 8 depicts the variance of Urbach energy, E_U and steepness parameter for CdCl₂ and MgCl₂-treated samples compared to that of as deposited CdTe films. E_U of the treated films shows an increasing tendency compared to the as deposited samples. Additionally, Fig. 8(bottom) illustrates overall a linear increment of E_U for MgCl₂-treated samples whereas there is no particular pattern for CdCl₂-treated films. These parameters are prominently depending on the absorbance of the film. An exponential rise in absorbance with $h\nu$ characterizes the E_U . By characterizing electron transport, it is utilized to quantify energy disorder at a semiconductor's band edges. E_U might be exploited as the index of the excellence of the thin-film absorbers as reduced E_U yields the increases in the V_{OC} and FF.⁴⁹ So, CdCl₂-treated films are expected to yield more V_{OC} and FF in the CdTe solar cell. It measures the steepness where absorption begins to occur close to the band edge and, thus, it also evaluates the range of the density of

Table 3 Optical parameters of CdCl₂ and MgCl₂-treated CdTe thin films

| Sample | Band gap, E_g (eV) | Refractive index, n | High frequency dielectric cont., ϵ_∞ | Dielectric cont., ϵ_0 |
|-----------|----------------------|-----------------------|--|--------------------------------|
| P 250 Cd | 1.56 | 2.885 | 8.321 | 13.715 |
| P 500 Cd | 1.50 | 2.913 | 8.485 | 13.900 |
| P 750 Cd | 1.48 | 2.923 | 8.542 | 13.962 |
| P 1000 Cd | 1.49 | 2.918 | 8.514 | 13.931 |
| P 250 Mg | 1.50 | 2.913 | 8.485 | 13.900 |
| P 500 Mg | 1.53 | 2.899 | 8.402 | 13.808 |
| P 750 Mg | 1.60 | 2.866 | 8.216 | 13.592 |
| P 1000 Mg | 1.55 | 2.889 | 8.347 | 13.746 |



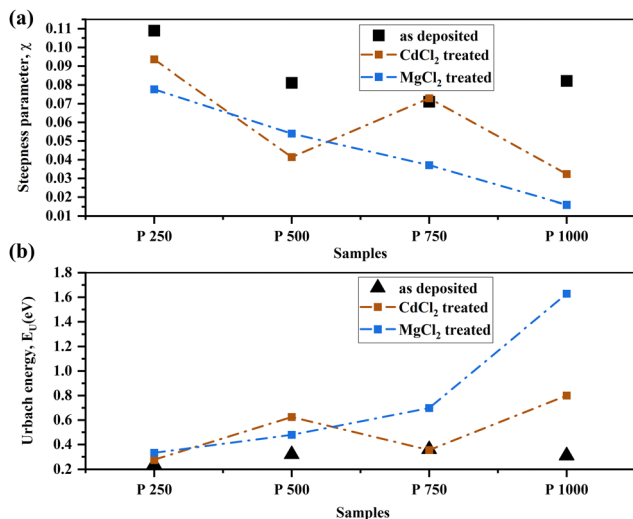


Fig. 8 Urbach energy (bottom) and steepness parameter, σ (top) of CdCl_2 and MgCl_2 -treated CdTe thin film.

states. A lower E_U is indicated by an abrupt absorption onset. Steepness parameter, on the other hand, is inversely proportional to E_U , portraying the enlargement of the optical absorption edge owing to electron-phonon interactions in a semiconductor. Thus, it is showing a decreasing tendency for the treated CdTe films. So CdCl_2 -treated CdTe film is expected to be more beneficial for high efficiency solar cells, though it will depend mostly on a complete structure and detailed balance.

The determination of skin depth arises from the substantial dependence of conductivity in semiconducting materials on the optical band gap.

$$\chi = \frac{1}{\alpha} \quad (3)$$

In this context, the symbol χ represents the skin depth, which refers to the depth at which the electromagnetic field intensity decreases by a factor of e^{-1} . On the other hand, α denotes the absorption coefficient of the thin film, which quantifies the extent to which the film absorbs incident electromagnetic radiation. There exists a correlation between the square root of the resistivity of a good conductor and the variable χ . Consequently,

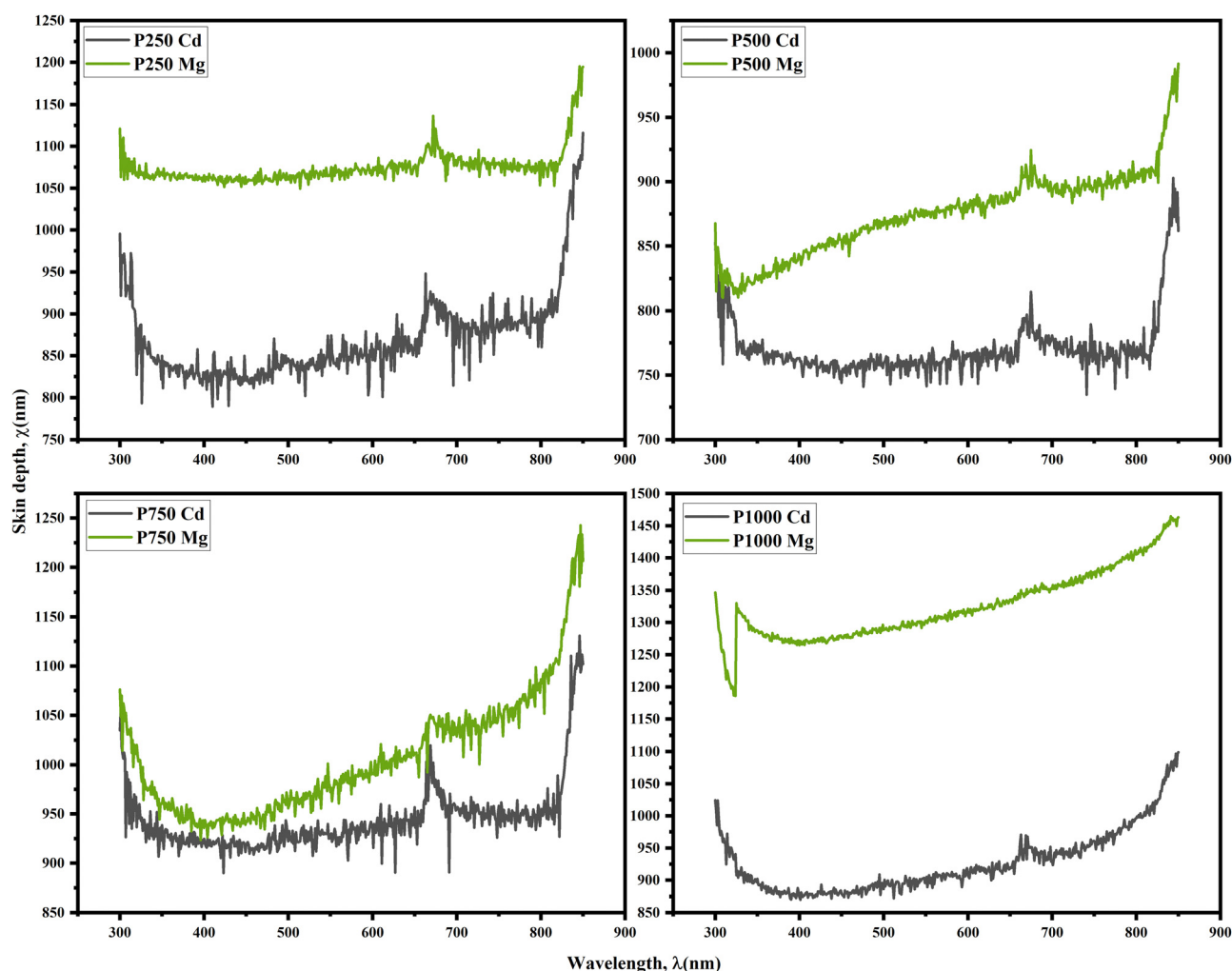


Fig. 9 Dependence of skin depth, χ of the CdTe film with wavelength.



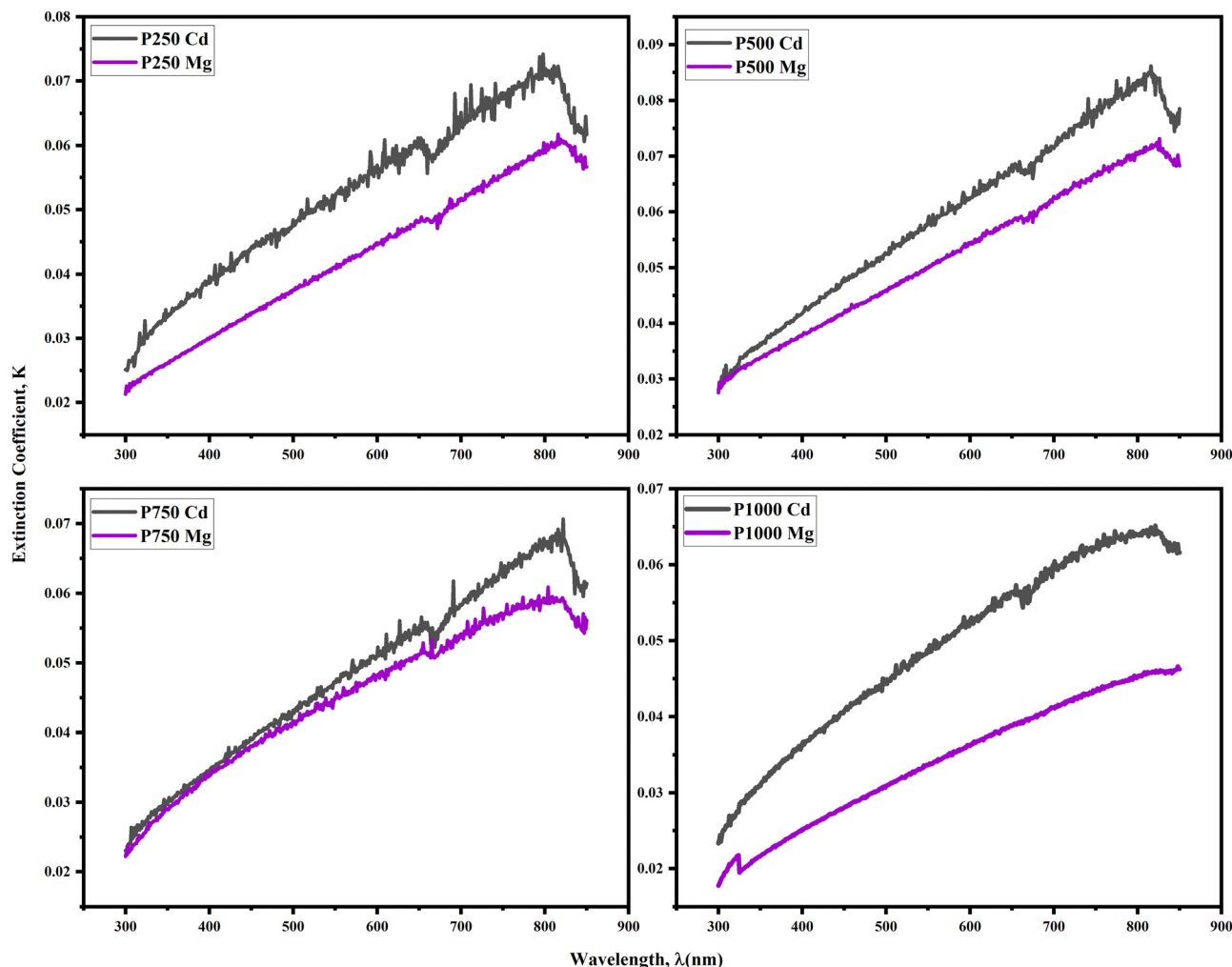


Fig. 10 Dependence of extinction coefficient of CdTe film on wavelength.

materials with higher conductivity have shallower skin depths. The dependency of χ on incident light wavelength for CaCl_2 and MgCl_2 -treated CdTe thin films is revealed in Fig. 9. χ seems to be high in the ultraviolet range; however, it rapidly drops and stabilizes as the wavelength increases in the visible zone. There is an abrupt change near the wavelength of 700 nm, which is expected due to the detector change of the UV-Vis spectrometer. Moreover, it demonstrates that all the CdTe samples treated with CdCl_2 show smaller values of χ and the MgCl_2 -treated CdTe films possess greater values. This again confirms higher absorption by CdCl_2 -treated CdTe thin films. So it can be concluded that the films with higher absorbance have lower χ , which provides an idea of why high absorption reduces the film's transmittance and restricts the amount of light that may pass through it.

Fig. 10 illustrates the relationship between the extinction coefficient (K)⁵⁰ of the thin CdTe film treated with CdCl_2 and MgCl_2 . K has a lower value in the ultraviolet region; however, it increases linearly as the wavelength increases in the visible range. Here, the abrupt modification of K near 700 nm is again visible. For spectrometers with dual detectors, this behavior is typical. The mechanical alignment of both detectors must be

perfect, and the intensity of light output must be adjusted to avoid it. Additionally, Fig. 10 demonstrates that all the CdTe samples treated with CdCl_2 had greater values of K and the MgCl_2 -treated CdTe films possess smaller values of that. This behavior may be in agreement with Fig. 6 because it is exactly relational to α and the material width of the film. The lower values of K signify a thin film's surface that is relatively smoother and less likely to lose light energy through scattering and absorption. So here we can conclude that the best performance is expected from MgCl_2 -treated absorber CdTe films as they lose less light.

4. Conclusions

The major commercially credible alternative option to silicon-based solar technology is now CdTe thin-film solar cells. This communication effort effectively integrated the knowledge by assessment of two effective chloride treatments with MgCl_2 and conventional CdCl_2 . It is demonstrated that the modification of the grain boundaries by chlorine results in an upsurge in structural attributes. Therefore, to attain high conversion



efficiencies, the performance of the CdTe absorber layer relies on the chloride activation process as it enhances its structural n optical properties. The reported work presents experimental findings in favor of a non-toxic, environmentally friendly MgCl_2 therapy, which can substitute CdCl_2 . For the CdCl_2 treated film, the average crystallite size synchronously expanded from 67 to 74 nm. Additionally, it varies from 71 to 82 nm for MgCl_2 -treated CdTe samples. SEM analysis suggests that the MgCl_2 treatment affects crystal formation more strongly, producing characteristics that are more defined and sharp. However, the MgCl_2 -treated samples have higher Urbach energy and skin depth and lower extinction coefficient. It is further demonstrated that film stoichiometry can also be controlled with these treatments to achieve p or n-type CdTe films depending on the module configuration. Consequently, concentrating on better or more regulated grain boundary treatments would offer a way to increase the cell voltages and hence power conversion efficiency. Considering structural and other physical properties, MgCl_2 might be a perfect alternative to CdCl_2 for manufacturing use as it is non-toxic and ecologically sound. Nevertheless, it is demonstrated in this study that there is still room for advancement. The CdCl_2 treatment in the presence of oxygen, according to scientific literature, results in superior devices. To comprehend this processing step, it is important to thoroughly investigate the presence of oxygen in the material and finally, the MgCl_2 -treated device configuration. A comprehensive investigation is also needed on the impact of Cd richness in removing Te-precipitation in CdTe focusing on XPS, AFM and electrical analysis. In this manner, the next work is proceeding.

Data availability

The dataset generated during analysis during the current study is available from the corresponding author on reasonable request.

Author contributions

AS – formal analysis, investigation, methodology, visualization, writing – original draft; SSM – investigation, methodology; MS – investigation, visualization; MAAS – funding acquisition, writing & editing; and MSB – conceptualization, supervision, resources, investigation, project administration.

Conflicts of interest

This work has been executed at our laboratory as a locally funded project as acknowledged accordingly. No conflict of interest exists with any parties other than acknowledged in the acknowledgment section.

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